



**TREND
FAIR 2011**

ELECTROMAGNETIC WAVE CHAOS IN 3D CAVITIES



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PURPOSE

To determine the applicability of the Random Coupling Model in predicting the susceptibility of a circuit in a 3D cavity not known to produce wave chaos.

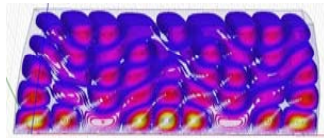
INTRODUCTION

Assumptions

- 1) $\lambda \gg L$
 - Treat EM waves as optical rays
- 2) $n \gg 1$
 - Many modes within cavity
- 3) Random Plane Wave Hypothesis
 - Local field is superposition of many plane waves

Implications

- 1) System is wave chaotic
- 2) Ray orbits are exponentially sensitive



- Complexity of modes at equilibrium within a cavity

RANDOM COUPLING MODEL

Cavity Impedance

$$Z = j \text{Im}[Z_{rad}] + \ddot{z} \text{Re}[Z_{rad}]$$

Cavity Impedance expressed as an expansion over the M modes in the cavity

$$Z(k) = \frac{-j}{\pi} \sum_{n=1}^M \Delta k_n^2 \frac{R_R(k_n) w_n^2}{k^2 (1 - j/Q_{ul}) - k_n^2}$$

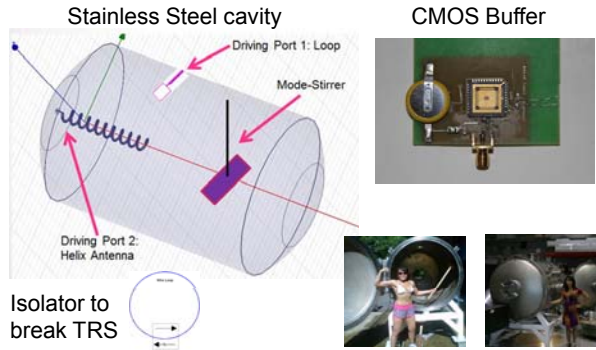
Radiation Impedance characterizes the system-specific coupling of any arbitrary port geometry to the cavity

$$Z_{rad}(k) = \frac{-j}{\pi} \int_0^\infty \frac{dk_n^2}{k^2 - k_n^2} R_R(k_n)$$

Normalized Impedance characterizes the universal aspects of the cavity

$$\ddot{z} = \frac{(Z - j \text{Im}[Z_{rad}])}{\text{Re}[Z_{rad}]}$$

APPARATUS



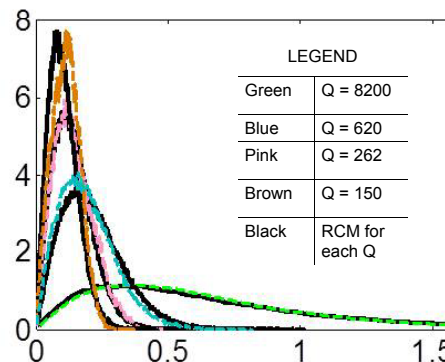
BASIC PARAMETERS

# of Absorbers:	4	2	1	0
Quality Factor (Q):	150	262	620	8200

Volume	2.16 m ³
Surface Area	9.38 m ²
Mean Mode Spacing	.291 m ⁻²

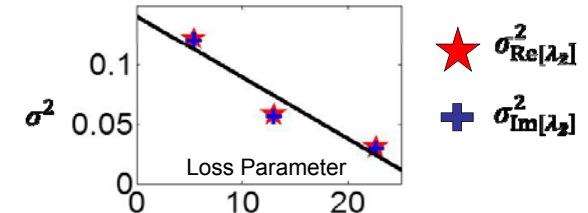
RESULTS

a) Comparison of experimental probability density functions (PDFs) with RCM predictions of PDFs

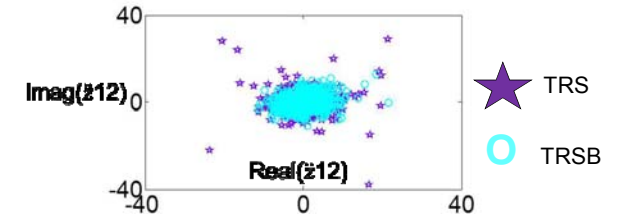


RESULTS

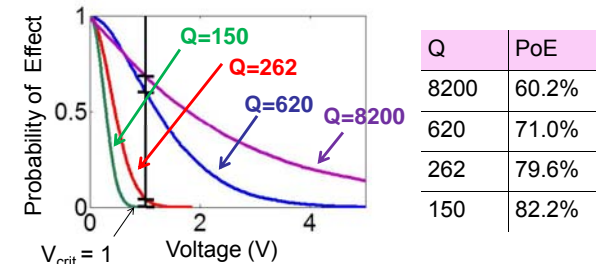
b) Variance vs. Loss Parameter for Q = 620, 262, 150



c) Real(z12) vs. Imag(z12) in TRS and TRSB for Q=8200



d) RCM predictions of cumulative distribution functions



CONCLUSIONS

- **Verified applicability of RCM to a general cavity**
 - Predicted experimental PDFs using measured Q's
 - Confirmed RCM theory that $\sigma_{\text{Re}[\lambda_2]}^2 \cong \sigma_{\text{Im}[\lambda_2]}^2$
 - Measured reduced variance in TRSB
- **Qualitatively assessed method of predicting PoE of a circuit using only 6 inputs to RCM**

FUTURE WORK

- Investigate more extreme loss cases
- Develop an equivalent circuit model to calculate voltage statistics for arbitrary port impedances
- Refine experimental procedure to measuring Q